

UT3N06-L

Power MOSFET

N-CHANNEL ENHANCEMENT
MODE POWER MOSFET

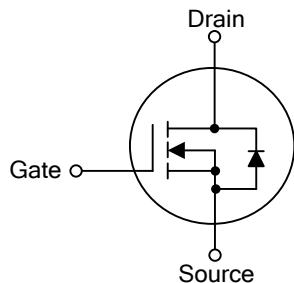
■ DESCRIPTION

The UTC UT3N06-L is an N-channel power MOSFET providing very low on-resistance. It has high efficiency and perfect cost-effectiveness. It can be generally applied in the commercial and industrial fields.

■ FEATURES

- * Simple drive requirement

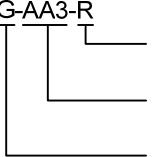
■ SYMBOL



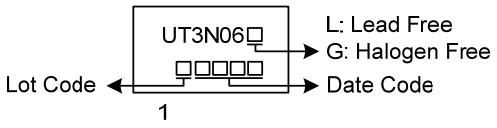
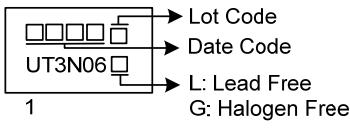
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UT3N06L-AA3-R	UT3N06G-AA3-R	SOT-223	G	D	S	Tape Reel
UT3N06L-AB3-R	UT3N06G-AB3-R	SOT-89	G	D	S	Tape Reel
UT3N06L-AE2-R	UT3N06G-AE2-R	SOT-23-3	G	S	D	Tape Reel
UT3N06L-AE3-R	UT3N06G-AE3-R	SOT-23	G	S	D	Tape Reel

Note: Pin Assignment: G: Gate S: Source D: Drain

 UT3N06G-AA3-R	(1)Packing Type	(1) R: Tape Reel
	(2)Package Type	(2) AA3: SOT-223, AB3: SOT-89, AE2: SOT-23-3, AE3: SOT-23
	(3)Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free

■ MARKING

SOT-223	SOT-89
 <p>UT3N06 Date Code Lot Code</p>	 <p>UT3N06 Date Code Lot Code L: Lead Free G: Halogen Free</p>
SOT-23-3 / SOT-23	-
 <p>L3N06</p>	-

■ ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	60	V
Gate-Source Voltage		V_{GSS}	± 20	V
Continuous Drain Current	Continuous	I_D	3	A
Pulsed Drain Current	Pulsed (Note 2)	I_{DM}	6	A
Power Dissipation	SOT-223	P_D	1.25	W
	SOT-23-3		0.3	W
	SOT-23/SOT-89		0.5	W
Junction Temperature		T_J	+150	$^\circ\text{C}$
Storage Temperature Range		T_{STG}	-55 ~ +150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

■ THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT
Junction to Ambient	SOT-223	θ_{JA}	100	$^\circ\text{C/W}$
	SOT-23-3		416	$^\circ\text{C/W}$
	SOT-23		250	$^\circ\text{C/W}$
	SOT-89		125	$^\circ\text{C/W}$

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

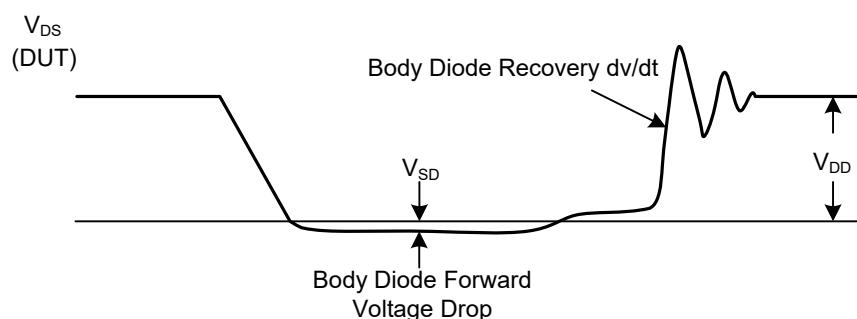
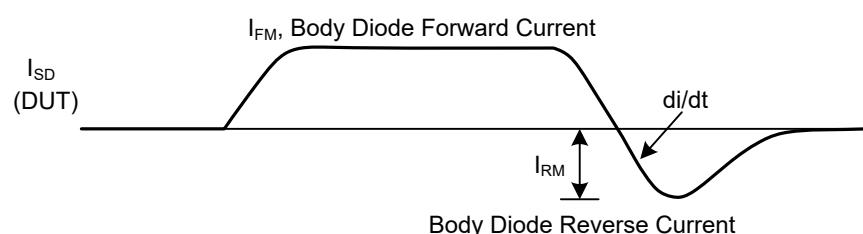
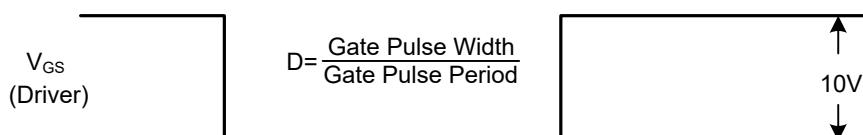
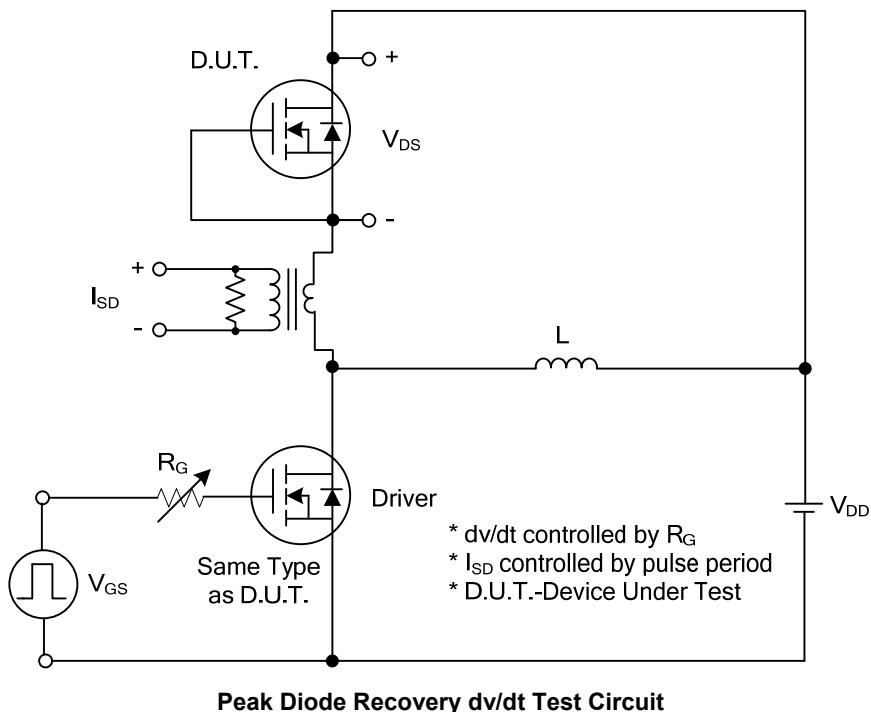
■ ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}} = 0\text{V}, I_{\text{D}} = 250\mu\text{A}$	60			V
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}} = 60\text{V}, V_{\text{GS}} = 0\text{V}$			1	μA
Gate-Source Leakage Current	I_{GSS}	$V_{\text{GS}} = \pm 20\text{V}$			± 100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{\text{GS}(\text{TH})}$	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 250\mu\text{A}$	0.5		1.5	V
Drain to Source On-state Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = 10\text{V}, I_{\text{D}} = 3.0\text{A}$			110	$\text{m}\Omega$
		$V_{\text{GS}} = 4.5\text{V}, I_{\text{D}} = 2.0\text{A}$			150	$\text{m}\Omega$
		$V_{\text{GS}} = 3.3\text{V}, I_{\text{D}} = 1.0\text{A}$			250	$\text{m}\Omega$
DYNAMIC PARAMETERS						
Input Capacitance	C_{ISS}	$V_{\text{DS}} = 25\text{V}, V_{\text{GS}} = 0\text{V}, f = 1.0\text{MHz}$		170		pF
Output Capacitance	C_{OSS}			30		pF
Reverse Transfer Capacitance	C_{RSS}			20		pF
SWITCHING PARAMETERS						
Total Gate Charge (Note)	Q_G	$V_{\text{DS}} = 48\text{V}, V_{\text{GS}} = 10\text{V}, I_{\text{D}} = 3.0\text{A}$ $I_G = 1\text{mA}$ (Note 1, 2)		12		nC
Gate Source Charge	Q_{GS}			2		nC
Gate Drain Charge	Q_{GD}			1.8		nC
Turn-ON Delay Time (Note)	$t_{\text{D}(\text{ON})}$			5		ns
Turn-ON Rise Time	t_R			14		ns
Turn-OFF Delay Time	$t_{\text{D}(\text{OFF})}$			13		ns
Turn-OFF Fall-Time	t_F			8		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Continuous Drain-Source Diode Forward Current	I_S				3	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				6	A
Drain-Source Diode Forward Voltage (Note)	V_{SD}	$I_S = 3\text{A}, V_{\text{GS}} = 0\text{V}$			1.4	V

Notes: 1. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$.

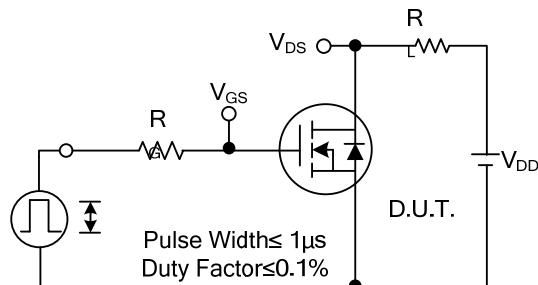
2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

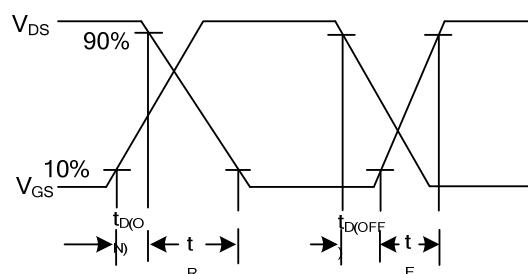


Peak Diode Recovery dv/dt Waveforms

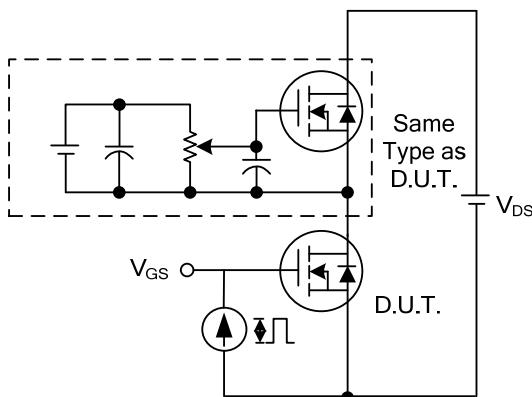
■ TEST CIRCUITS AND WAVEFORMS



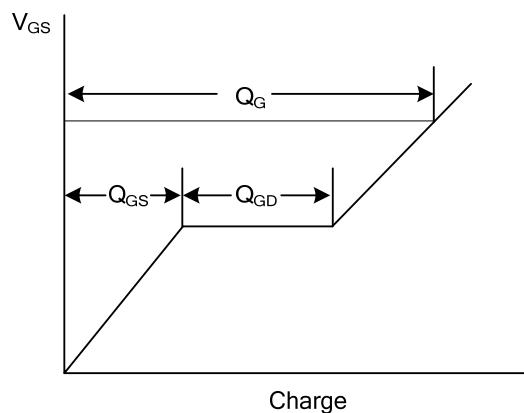
Switching Test Circuit



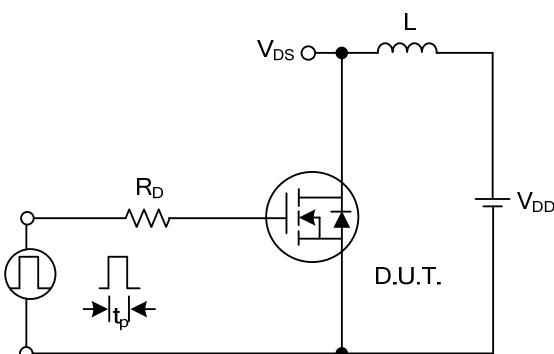
Switching Waveforms



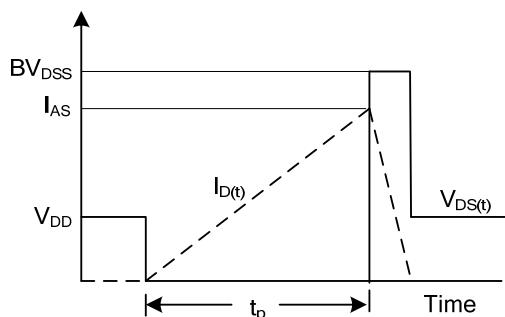
Gate Charge Test Circuit



Gate Charge Waveform

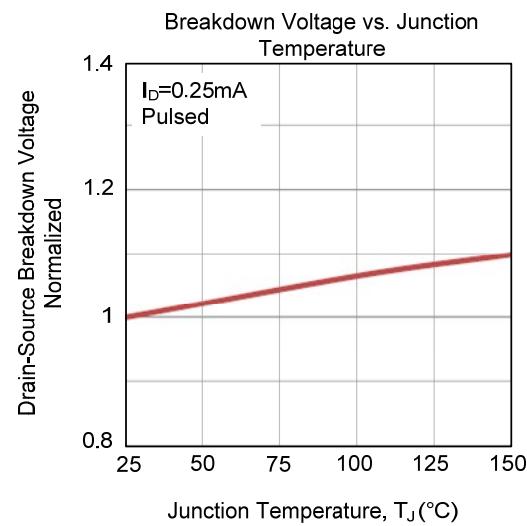
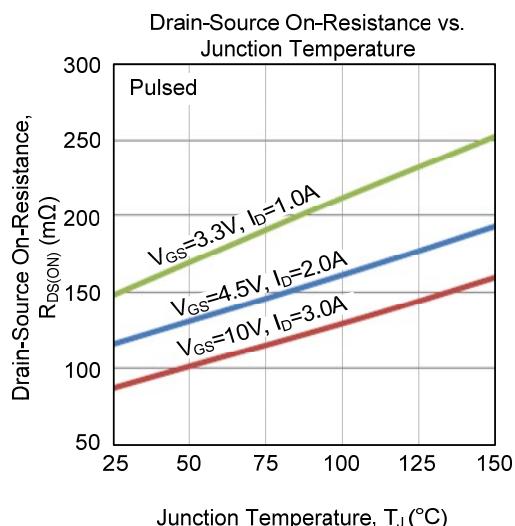
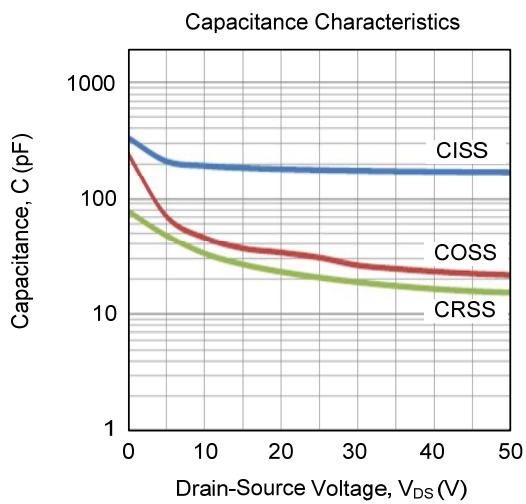
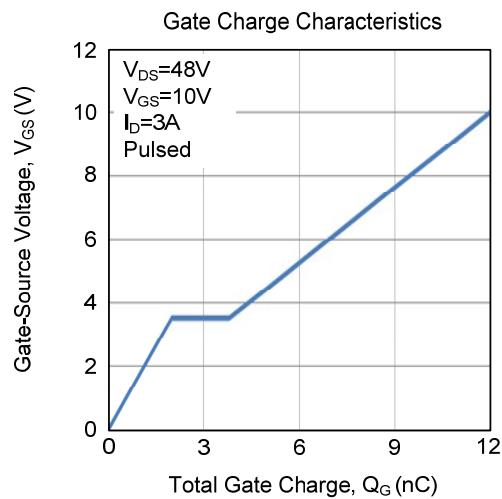
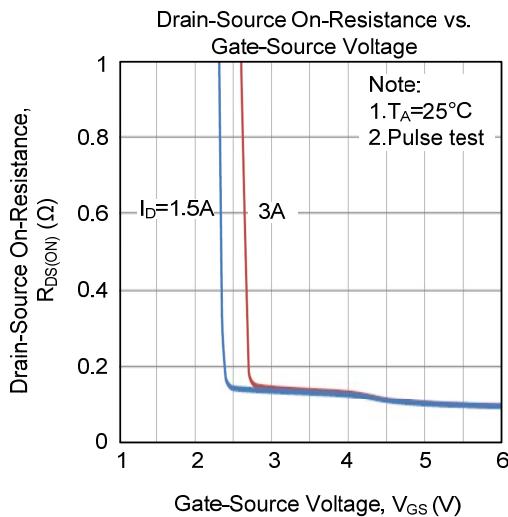
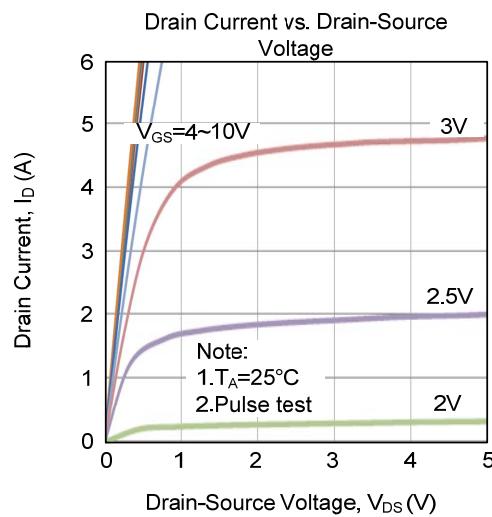


Unclamped Inductive Switching Test Circuit

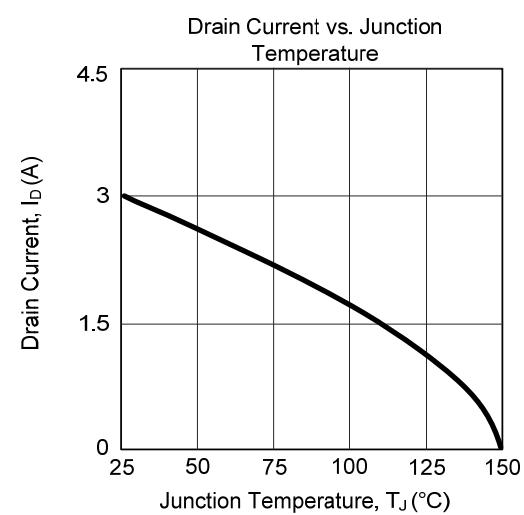
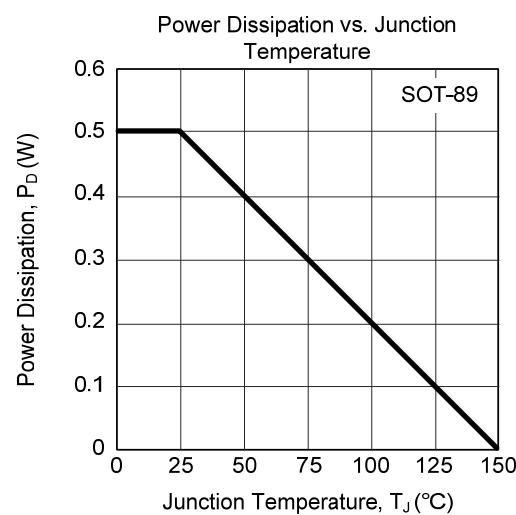
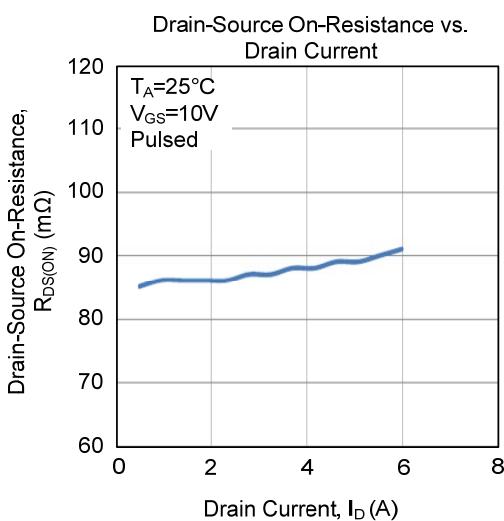
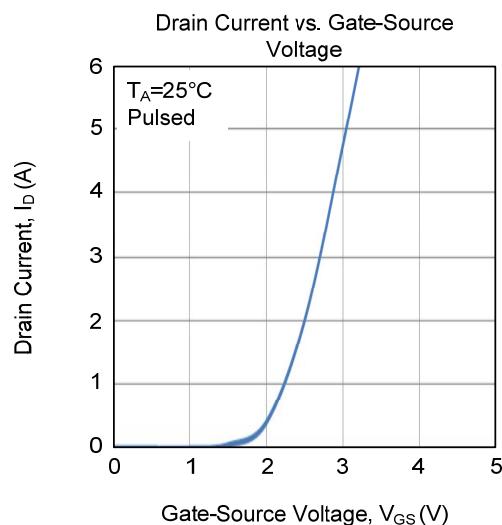
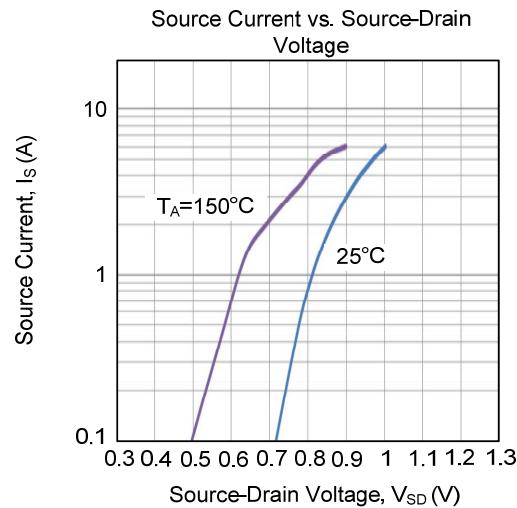
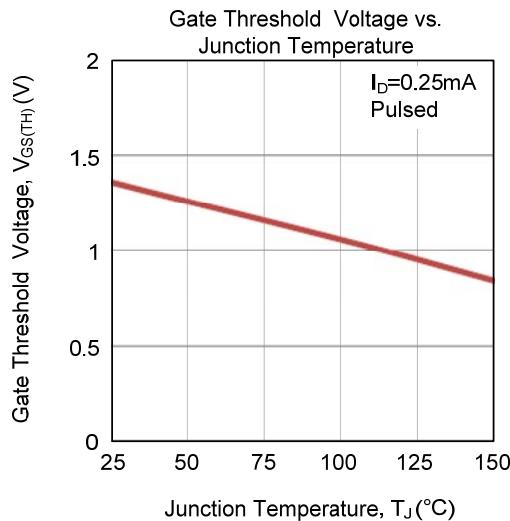


Unclamped Inductive Switching Waveforms

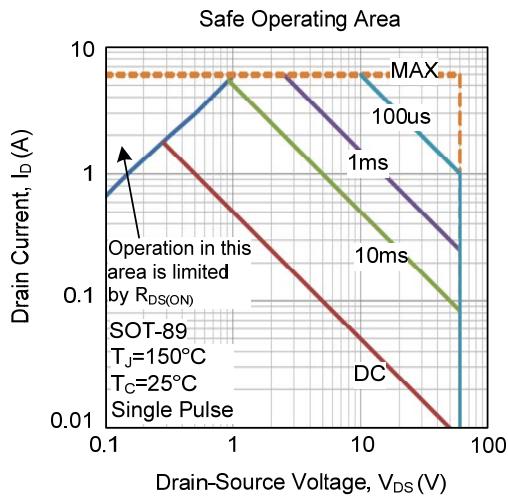
■ TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)



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